Notice of References Cited Application/Control No. 10/599,731 Examiner DIMPLE N. BODAWALA Applicant(s)/Patent Under Reexamination HOWE ET AL. Page 1 of 2

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | Α | US-3,450,295 A | 06-1969 | WEBER FRED C JR | 220/561 |
| * | В | US-3,689,320 A | 09-1972 | Ashcroft et al. | 419/35 |
| * | С | US-4,409,270 A | 10-1983 | Faber et al. | 428/63 |
| * | D | US-4,659,525 A | 04-1987 | Speer, Lawrence L. | 264/36.22 |
| * | Е | US-5,118,454 A | 06-1992 | Preston, Frank J. | 264/36.11 |
| * | F | US-5,166,007 A | 11-1992 | Smith et al. | 428/63 |
| * | G | US-5,490,965 A | 02-1996 | Christiansen, Frank J. | 264/237 |
| * | Н | US-5,616,396 A | 04-1997 | Ueki et al. | 428/139 |
| * | ı | US-5,788,888 A | 08-1998 | Cohen et al. | 264/28 |
| * | J | US-5,852,854 A | 12-1998 | Pierrot et al. | 24/297 |
| * | К | US-5,937,486 A | 08-1998 | Bockenheimer, Alexander | 24/297 |
| * | Ĺ | US-6,103,047 A | 08-2000 | Ogawa, Taro | 156/245 |
| * | М | US-2002/0038923 A1 | 04-2002 | Lenherr, Otto | 264/221 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------|----------------|
| | N | JP 61132473 A | 06-1986 | Japan | MAEDA, RYOJI | B62D 25/20 |
| | 0 | | | | | |
| | Р | | | | | / |
| - | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | _ | | | | 100 | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/599,731 Examiner DIMPLE N. BODAWALA Applicant(s)/Patent Under Reexamination HOWE ET AL. Page 2 of 2

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | Α | US-6,386,236 B1 | 05-2002 | Buckley, David L. | 138/99 |
| * | В | US-2003/0047268 A1 | 03-2003 | Korchnak et al. | 156/94 |
| * | O | US-6,562,477 B1 | 05-2003 | Leon et al. | 428/500 |
| * | D | US-6,632,498 B1 | 10-2003 | Zimmermann et al. | 428/40.1 |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Ι | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.